

Rev3: Nov 2004

AOD410, AOD410L (Green Product) N-Channel Enhancement Mode Field Effect Transistor

General Description

The AOD410 uses advanced trench technology to provide excellent $R_{\text{DS(ON)}}$ and low gate charge. This device is suitable for use as a load switch or in PWM applications. AOD410L(Green Product) is offered in a lead-free package.

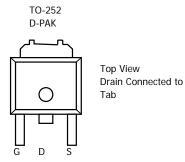
Features

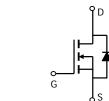
 $V_{DS}(V) = 30V$

 $I_D = 8A$

 $R_{DS(ON)}$ < 65m Ω (V_{GS} = 10V)

 $R_{DS(ON)}$ < 105m Ω (V_{GS} = 4.5V)





Absolute Maximum Ratings T _A =25°C unless otherwise noted							
Parameter		Symbol	Maximum	Units			
Drain-Source Voltage		V_{DS}	30	V			
Gate-Source Voltage		V_{GS}	±20	V			
Continuous Drain	T _C =25°C		8				
Current ^G	T _C =100°C	I_D	6	Α			
Pulsed Drain Current ^B		I _{DM}	20				
Avalanche Current ^C		I _{AR}	8	Α			
Repetitive avalanche energy L=0.1mH ^C		E _{AR}	10	mJ			
	T _C =25°C	D	25	W			
Power Dissipation ^B	T _C =100°C	P _D	12.5	VV			
	T _A =25°C	В	2.1	W			
Power Dissipation ^A	T _A =70°C	P _{DSM}	1.33	VV			
Junction and Storage Temperature Range		T_J , T_{STG}	-55 to 175	°C			

Thermal Characteristics								
Parameter	Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient A	t ≤ 10s	$R_{ heta JA}$	20	30	°C/W			
Maximum Junction-to-Ambient A	Steady-State	Г	46	60	°C/W			
Maximum Junction-to-Case ^C	Steady-State	$R_{ heta JL}$	5.3	7	°C/W			

Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter Conditions		Min	Тур	Max	Units				
STATIC PARAMETERS										
BV_{DSS}	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	30			V				
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =24V, V _{GS} =0V			1	μА				
		T _J =55	°C		5	μΛ				
I_{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} = ±20V			100	nA				
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS} I_{D}=250 \mu A$	1	1.8	3	V				
$I_{D(ON)}$	On state drain current	V_{GS} =4.5V, V_{DS} =5V	10			Α				
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =8A		48	65	mΩ				
		T _J =125	°C	76	100	1112.2				
		V _{GS} =4.5V, I _D =2A		75	105	mΩ				
g _{FS}	Forward Transconductance	$V_{DS}=5V$, $I_{D}=8A$		6.2		S				
V_{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V		0.75	1	V				
I_S	Maximum Body-Diode Continuous Curre			4.3	Α					
DYNAMIC	PARAMETERS									
C_{iss}	Input Capacitance			288		pF				
C _{oss}	Output Capacitance	V_{GS} =0V, V_{DS} =15V, f=1MHz		57		pF				
C_{rss}	Reverse Transfer Capacitance			39		pF				
R_g	Gate resistance	V_{GS} =0V, V_{DS} =0V, f=1MHz		3		Ω				
SWITCHII	NG PARAMETERS									
Q _g (10V)	Total Gate Charge			6.72		nC				
Q _g (4.5V)	Total Gate Charge	V _{GS} =10V, V _{DS} =15V, I _D =8A		3.34		nC				
Q_{gs}	Gate Source Charge			0.76		nC				
Q_{gd}	Gate Drain Charge			1.78		nC				
t _{D(on)}	Turn-On DelayTime			3.7		ns				
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =15V, R_L =1.8 Ω ,		3.7		ns				
t _{D(off)}	Turn-Off DelayTime	$R_{GEN}=3\Omega$		15.6		ns				
t _f	Turn-Off Fall Time			2.6		ns				
t _{rr}	Body Diode Reverse Recovery Time	I _F =8A, dI/dt=100A/μs		12.6		ns				
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =8A, dI/dt=100A/μs		5.1		nC				

A: The value of $R_{\theta JA}$ is measured with the device mounted on 1in^2 FR-4 board with 2oz. Copper, in a still air environment with T_A =25°C. The Power dissipation P_{DSM} is based on $R_{\theta JA}$ and the maximum allowed junction temperature of 150°C. The value in any a given application depends on the user's specific board design, and the maximum temperature fo 175°C may be used if the PCB allows it.

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B. The power dissipation P_D is based on $T_{J(MAX)}$ =175°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C: Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)}$ =175°C.

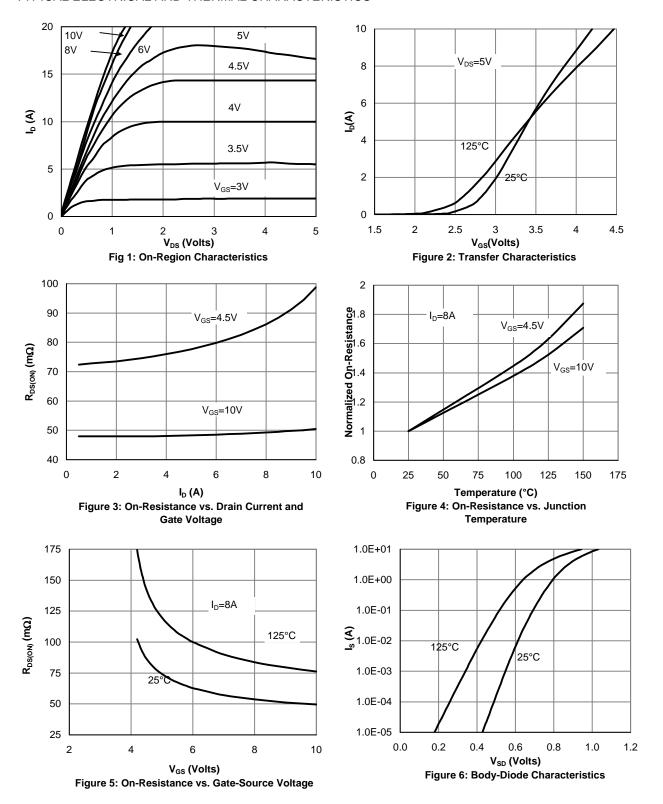
D. The R $_{\theta JA}$ is the sum of the thermal impedence from junction to case $R_{\theta JC}$ and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300 μs pulses, duty cycle 0.5% max.

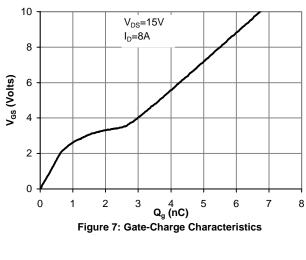
F. These tests are performed with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T_A =25°C. The SOA curve provides a single pulse rating.

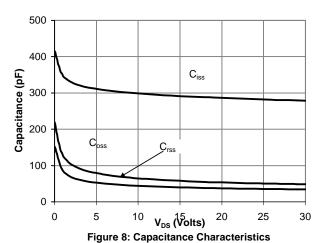
G. The maximum current rating is limited by bond-wires.

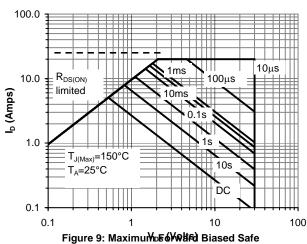
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



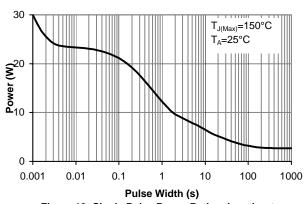
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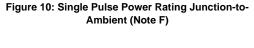






Onerating Area (Note F)





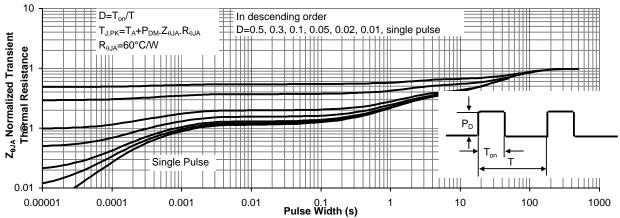


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)